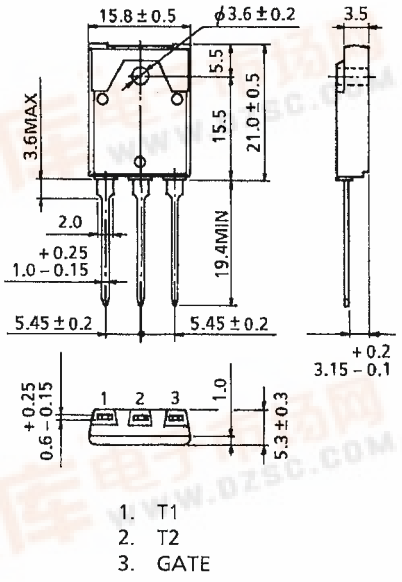
TOSHIBA BI-DIRECTIONAL TRIODE THYRISTOR ILICON PLANAR TYPE

SM25GZ51,SM25JZ51

Unit: mm

AC POWER CONTROL APPLICATIONS

- Repetitive Peak Off-State Voltage : V_{DRM} = 400, 600V
- R.M.S On-State Current : $I_{T\ (RMS)}$ = 25A
- High Commutating (dv / dt) : (dv / dt) c = 10V / μs
- Isolation Voltage : V_{Isol} = 1500V AC



JEDEC	—
JEITA	—
TOSHIBA	13-16A1A

Weight: 5.9g

MAXIMUM RATINGS

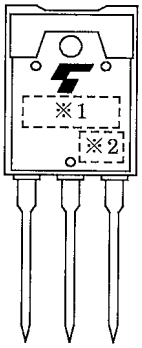
CHARACTERISTIC		SYMBOL	RATING	UNIT
Repetitive Peak Off-State Voltage	SM25GZ51	V_{DRM}	400	V
	SM25JZ51		600	
R.M.S On-State Current (Full Sine Waveform Tc = 73°C)		$I_{T\ (RMS)}$	25	A
Peak One Cycle Surge On-State Current (Non-Repetitive)		I_{TSM}	230 (50Hz)	A
			253 (60Hz)	
I^2t Limit Value		I^2t	260	A^2s
Critical Rate of Rise of On-State Current (Note 1)		di / dt	50	A / μs
Peak Gate Power Dissipation		P_{GM}	5	W
Average Gate Power Dissipation		$P_{G\ (AV)}$	0.5	W
Peak Gate Voltage		V_{GM}	10	V
Peak Gate Current		I_{GM}	2	A
Junction Temperature		T_j	−40~125	°C
Storage Temperature Range		T_{stg}	−40~125	°C
Isolation Voltage (AC, t = 1 min.)		V_{Isol}	1500	V

Note 1: di / dt Test Condition
V_{DRM} = 0.5 × Rated
$I_{TM} \leq 40A$
$t_{gw} \geq 10\mu s$
$t_{gr} \leq 250ns$
$i_{gp} = I_{GT} \times 2.0$

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

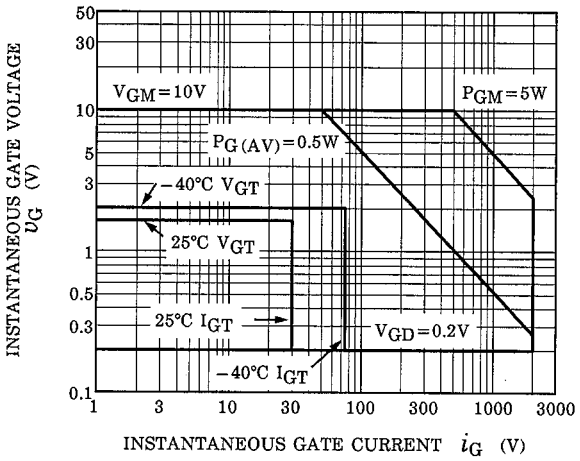
CHARACTERISTIC		SYMBOL	TEST CONDITION		MIN	TYP.	MAX	UNIT
Repetitive Peak Off−State Current		I_{DRM}	V_{DRM} = Rated		—	—	20	μA
Gate Trigger Voltage	I	V_{GT}	V_D = 12V, R_L = 20Ω	T2 (+) , Gate (+)	—	—	1.5	V
	II			T2 (+) , Gate (−)	—	—	1.5	
	III			T2 (−) , Gate (−)	—	—	1.5	
Gate Trigger Current	I	I_{GT}	V_D = 12V, R_L = 20Ω	T2 (+) , Gate (+)	—	—	30	mA
	II			T2 (+) , Gate (−)	—	—	30	
	III			T2 (−) , Gate (−)	—	—	30	
Peak On−State Voltage		V_{TM}	I_{TM} = 40A		—	—	1.5	V
Gate Non−Trigger Voltage		V_{GD}	V_D = Rated, Tc = 125°C		0.2	—	—	V
Holding Current		I_H	V_D = 12V, I_{TM} = 1A		—	—	60	mA
Thermal Resistance		$R_{th\ (j-c)}$	Junction to Case, AC		—	—	1.3	°C / W
Critical Rate of Rise of Off−State Voltage		dv / dt	V_{DRM} = Rated, T_j = 125°C Exponential Rise		—	300	—	V / μs
Critical Rate of Rise of Off−State Voltage at Commutation		(dv / dt) c	V_{DRM} = 400V, T_j = 125°C (di / dt) c = − 15A / ms		10	—	—	V / μs

MARKING

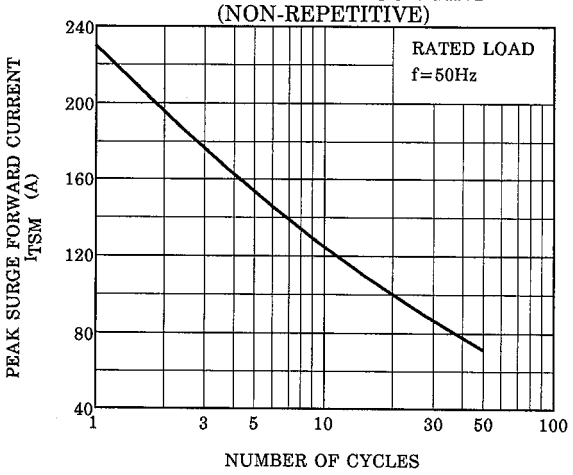


NUMBER	SYMBOL		MARK
*1	TYPE	SM25GZ51	M25GZ51
		SM25JZ51	M25JZ51
*2	Lot Number □□ Month (Starting from Alphabet A) Year (Last Decimal Digit of the Current Year)		Example 8A : January 1998 8B : February 1998 8L : December 1998

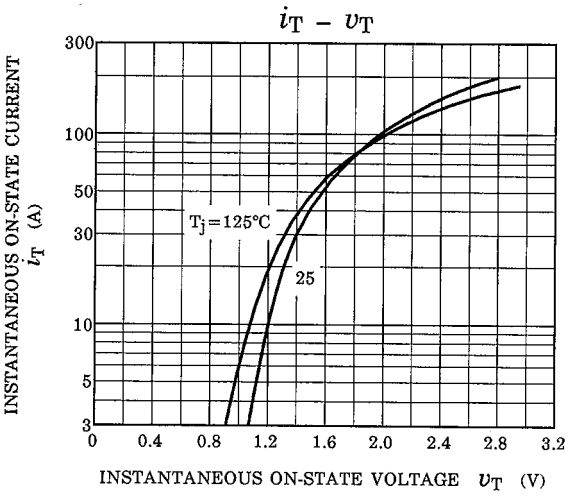
GATE TRIGGER CHARACTERISTIC



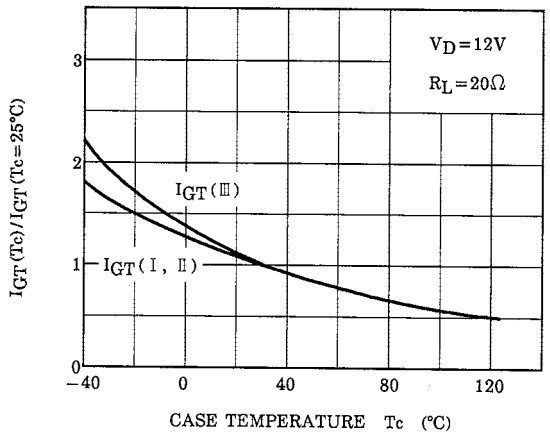
SURGE ON-STATE CURRENT
(NON-REPETITIVE)



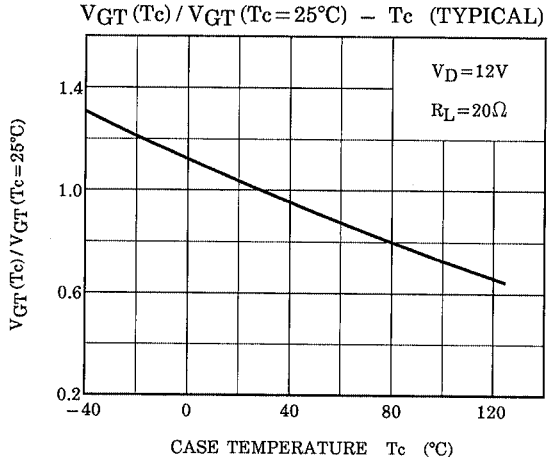
$i_T - v_T$



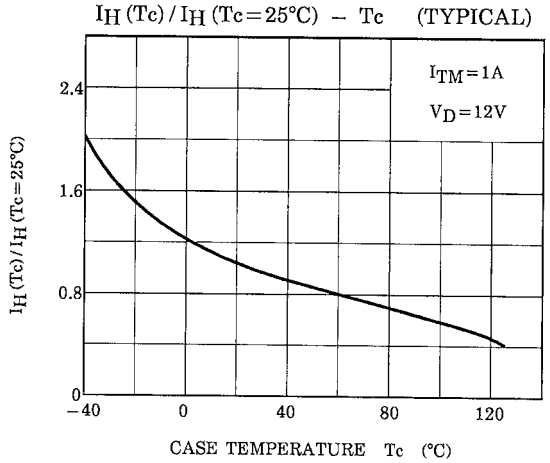
$I_{GT}(Tc) / I_{GT}(Tc=25°C)$ – Tc (TYPICAL)



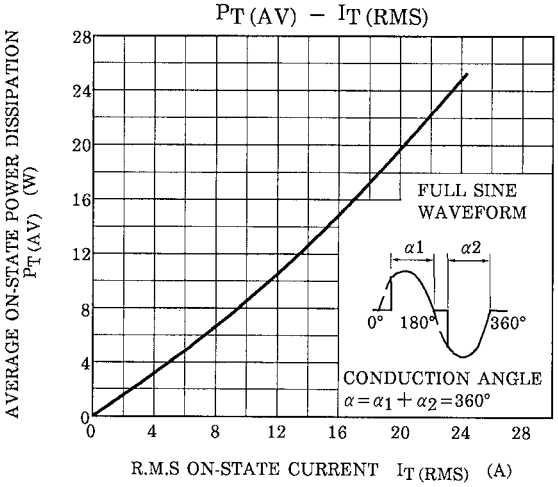
$V_{GT}(Tc) / V_{GT}(Tc=25°C)$ – Tc (TYPICAL)



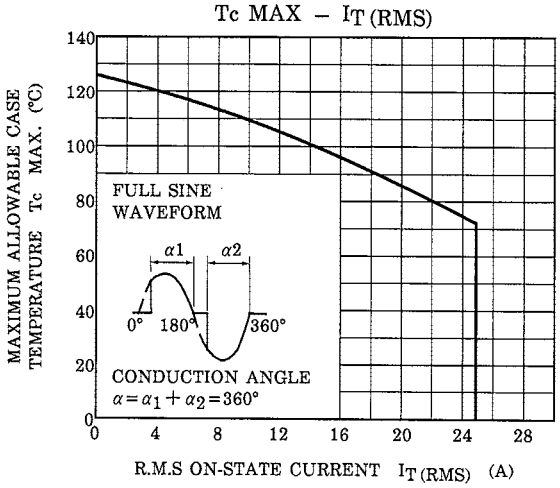
$I_H(Tc) / I_H(Tc=25°C)$ – Tc (TYPICAL)



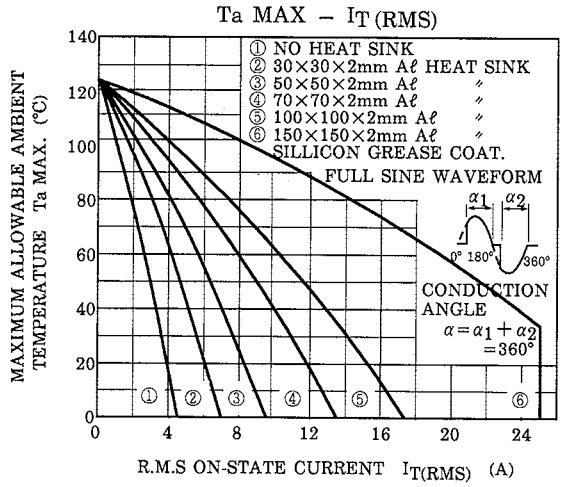
$P_{T(AV)}$ – $I_{T(RMS)}$



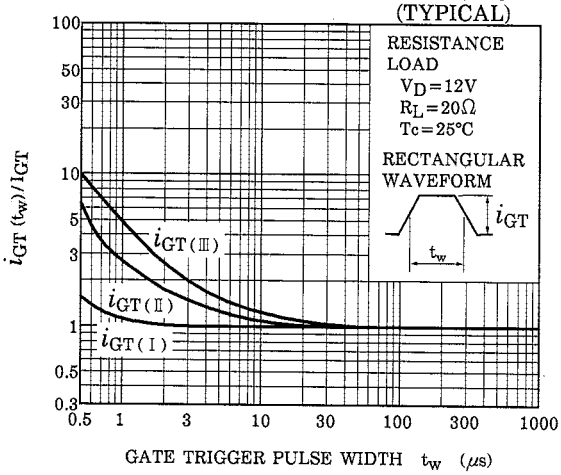
Tc MAX – $I_{T(RMS)}$



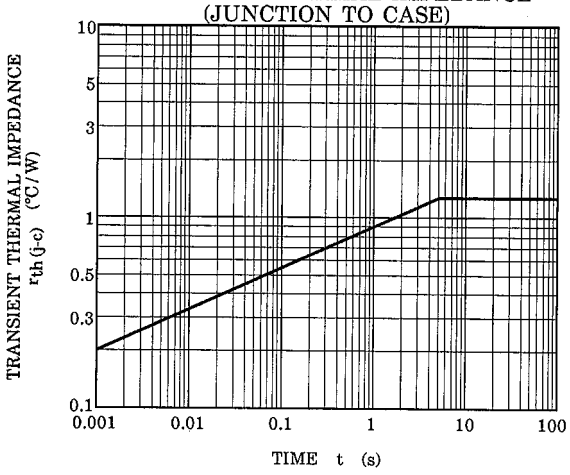
Ta MAX – $I_{T(RMS)}$



PULSE TRIGGER CHARACTERISTIC (TYPICAL)



TRANSIENT THERMAL IMPEDANCE (JUNCTION TO CASE)



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